

<b>Notice of References Cited</b>	Application/Control No. 09/994,887	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-6,584,111	06-2003	Aweya et al.	370/232
*	D	US-6,445,707	09-2002	luoras et al.	370/232
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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	U	
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